

<b>Notice of References Cited</b>	Application/Control No. 10/648,367	Applicant(s)/Patent Under Reexamination IIDA, TAKAYUKI	
	Examiner Julie E. Stein, Esq.	Art Unit 2685	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0171869	11-2002	Dibiashi et al.	358/1.16
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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